

<b>Search Notes</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10743731	KOBAYASHI, TAKEHIKO
	Examiner	Art Unit
	Nguyen, Leon-Viet Q	2611

### SEARCHED

Class	Subclass	Date	Examiner
375	330	3/1/07-3/2/07	LVN

### SEARCH NOTES

Search Notes	Date	Examiner
Inventor name search fo double patenting in PALM	3/1/07	LVN
EAST search history	3/1/07-3/2/07	LVN

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner